FORM PTO 1449 (modified)			ATTY DOCKET NO.	APPLICATION NO. 10/566,170		
	EPARTMENT OF COMMERC NT AND TRADEMARK OPFICE	78/	00862.109138. APPLICANT	NOBII SEKIGI		
UIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) (Use several sheets if necessary) (Use several sheets if necessary)			YOSHINOBU SEKIGUO 371(c) DATE January 27, 2006		GROUP 2818	
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ATTY DOCKET NO. APPLICATION NO. FORM PTO 1449 (modified) 10/566,170 00862,109138. U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE **APPLICANT** YOSHINOBU SEKIGUCHI, et al. LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) **GROUP** 371(c) DATE 2818 January 27, 2006 **U.S. PATENT DOCUMENTS** FILING DATE IF APPROPRIATE *EXAMINER DOCUMENT INITIAL NUMBER DATE NAME CLASS SUBCLASS /CL/ 89 117 6,331,208 12/18/01 Nishida, et al. 438 458 10/23/01 6,306,729 Sakaguchi, et al. 07/10/01 438 455 6,258,698 lwasaki, et al. 04/03/01 438 409 Nakagawa, et al. 6,211,038 438 67 6,190,937 02/20/01 Nakagawa, et al. 6,156,624 12/05/00 Yamagata, et al. 438 459 428 446 11/21/00 Yonehara 6,150,031 438 455 11/07/00 6,143,628 Sato, et al. 6,140,209 10/31/00 438 458 Iwane, et al. 117 54 08/22/00 6,106,613 Sato, et al. 409 438 5,970,361 10/19/99 Kumomi, et al. 02/09/99 216 2 5,868,947 Sakaguchi, et al. 5,840,616 11/24/98 Sakaguchi, et al. 438 459 5,763,288 06/09/98 Sakaguchi, et al. 438 455 05/26/98 Yonehara 156 281 5,755,914 Yonehara, et al. 156 630.1 05/12/98 5,750,000 438 62 5,712,199 01/27/98 Nakagawa, et al. /CL/ 437 86 5,371,037 12/06/94 Yonehara FOREIGN PATENT DOCUMENTS TRANSLATION DOCUMENT NUMBER SUBCLASS YES/NO/ DATE COUNTRY **CLASS** OR ABSTRACT OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.) /Calvin Lee/ (09/18/2007) | DATE CONSIDERED **EXAMINER**

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